

BS ISO 14490-6:2014



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Optics and photonics — Test methods for telescopic systems

Part 6: Test methods for veiling glare index

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National foreword

This British Standard is the UK implementation of ISO 14490-6:2014. It supersedes BS ISO 14490-6:2005 which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee CPW/172, Optics and Photonics.

A list of organizations represented on this committee can be obtained on request to its secretary.

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**Optics and photonics — Test methods
for telescopic systems —**

**Part 6:
Test methods for veiling glare index**

*Optique et photonique — Méthodes d'essai pour systèmes
télescopiques —*

Partie 6: Méthodes d'essai de l'indice de lumière parasite



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Foreword

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The committee responsible for this document is ISO/TC 172, *Optics and photonics*, Subcommittee SC 4, *Telescopic systems*.

This second edition cancels and replaces the first edition (ISO 14490-6:2005), of which it constitutes a minor revision. ISO 14490 consists of the following parts, under the general title *Optics and photonics — Test methods for telescopic systems*:

- *Part 1: Test methods for basic characteristics*
- *Part 2: Test methods for binocular systems*
- *Part 3: Test methods for telescopic sights*
- *Part 4: Test methods for astronomical telescopes*
- *Part 5: Test methods for transmittance*
- *Part 6: Test methods for veiling glare index*
- *Part 7: Test methods for limit of resolution*
- *Part 8: Test methods for night-vision devices*